

L Number	Hits	Search Text	DB	Time stamp
1	1834	(hard near3 detect) or (pattern near1 resistant)	USPAT; EPO; DERWENT	2004/03/11 10:15
2	1871771	(hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))	USPAT; EPO; DERWENT	2004/03/11 10:16
3	15	((hard near3 detect) or (pattern near1 resistant)) with ((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector)))	USPAT; EPO; DERWENT	2004/03/11 10:19
4	12364	testcube or (test adj cube) or (Test adj set)	USPAT; EPO; DERWENT	2004/03/11 10:20
5	2	((hard near3 detect) or (pattern near1 resistant)) same ((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set))	USPAT; EPO; DERWENT	2004/03/11 10:22
6	1097	((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set))	USPAT; EPO; DERWENT	2004/03/11 10:22
7	54	((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set)) same (fault or fail\$3 or error or defect)	USPAT; EPO; DERWENT	2004/03/11 10:28
8	1052	synchronous near1 (reset or preset or set)	USPAT; EPO; DERWENT	2004/03/11 10:29
9	0	((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set)) same (synchronous near1 (reset or preset or set))	USPAT; EPO; DERWENT	2004/03/11 10:29
10	1073	((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set)) same (reset or preset or set)	USPAT; EPO; DERWENT	2004/03/11 10:29
11	108272	((flip adj flop) or latch or register) near4 (reset or preset or set)	USPAT; EPO; DERWENT	2004/03/11 10:30
12	2	((hardware adj overhead) or weight or ((test or pattern or vector) near1 length) or (overrid\$3 near1 (signal or pattern or vector))) same (testcube or (test adj cube) or (Test adj set)) same ((flip adj flop) or latch or register) near4 (reset or preset or set)	USPAT; EPO; DERWENT	2004/03/11 10:30